

Notice of References Cited	Application/Control No. 10/538,763		Applicant(s)/Patent Under Reexamination SLONAKER, STEVEN DOUGLAS	
	Examiner KIBROM K. GEBRESILASSIE		Art Unit 2128	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,272,392 B1	08-2001	Capodieci, Luigi	700/110
*	B	US-2002/0159040 A1	10-2002	Hamatani et al.	355/52
*	C	US-2003/0091913 A1	05-2003	Shiode, Yoshihiro	430/22
*	D	US-2003/0081722 A1	05-2003	Kandaka et al.	378/70
*	E	US-2004/0053148 A1	03-2004	Morohoshi, Hiroshi	430/030
*	F	US-2004/0137677 A1	07-2004	Lowisch et al.	438/232
*	G	US-2005/0010878 A1	01-2005	Blatchford et al.	716/004
*	H	US-7,095,481 B2	08-2006	Morohoshi, Hiroshi	355/52
*	I	US-7,230,252 B2	06-2007	Muraki et al.	250/396R
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	T. Nakashima, S. D. Slonaker, T. Kudo, and S. Hirukawa, "Evaluation of Zernike sensitivity method for CD distribution", Vol. 5040 (2003), 2003 SPIE (June 2003).			
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.